

Search Notes

Application/Control No.

10/628,409

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

DELEPAUT, CHRISTOPHE

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	266		
	275		
	284		
	285		
	288		
	299		
	906		
320	102		
	149		
	161		
	162	3/05	JA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
323	284		
	285		
	906		
320	149		
	161	3/05	JA

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR